

Notice of References Cited	Application/Control No. 10/606,623		Applicant(s)/Patent Under Reexamination EID ET AL.	
	Examiner Devona E. Faulk		Art Unit 2615	Page 1 of 1

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-5,757,927	05-1998	Gerzon et al.	381/20
*	B	US-7,035,413	04-2006	Waller et al.	381/17
*	C	US-6,349,285	02-2002	Liu et al.	704/500
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	I	US-			
	J	US-			
	K	US-			
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	M	US-			

FOREIGN PATENT DOCUMENTS

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NON-PATENT DOCUMENTS

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*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
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